

TEST – DIAGNOSTICS – PROGNOSTICS – INSTRUMENTATION – LOGISTICS MANAGEMENT SYSTEMS – VERIFICATION – SOFTWARE – TEST PROGRAM SETS EMBEDDED INSTRUMENTS/SENSORS – BIT/BITE NETCENTRIC MAINTENANCE AND SUSTAINMENT FROM FACTORY TO FIELD

On behalf of the IEEE Aerospace and Electronics Systems and Instrumentation and Measurement Societies we invite you to join us in 2010 at the Systems Readiness Technology Conference, popularly known as AUTOTESTCON, in Orlando, Florida.

Our conference theme, "45 Years of Support Innovation – Moving Forward at the Speed of Light", reflects that 2010 marks the 45th year of AUTOTESTCON and how our technical program is focused on the future of automatic test. Attendees will have the opportunity to preview many new products from a wide variety of exhibitors, and to meet with senior military and aerospace leaders to discuss their future needs and expectations. As an AUTOTESTCON attendee, you'll have the opportunity to:

- » Engage in discussion about new system readiness and test technologies
- » Consult colleagues and industry professionals about the changing needs of client applications
- » Discover innovative technical and management approaches
- » Explore well over 250 exhibit booths presented by over 100 exhibiting companies and US military divisions
- » Interact with weapon systems managers, acquisition officials, engineers and logisticians
- » Listen to and interact with the world's best in Automatic Test

The Conference will be held 13-16 September 2010 at the spectacular Marriott Orlando World Center Resort & Convention Center. We promise you an exciting week of professional and social activities in one of the U.S.'s great destinations. Come join us at the New York Street Party at Universal Studios for a very special evening! Make your plans for a great day of golf at the Shingle Creek Golf Club voted one of the "Top 40 Best New Golf Courses in the U.S." by Golfweek Magazine.

